Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/764,585	MAEHARA, HARUHIK	0
Examiner	Art Unit	
David D. Davis	2652	

SEAR	SEARCHED		
Subclass	Date	Examiner	
	Subclass	Subclass Date	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See attached	12/11/2005	DDD		
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